

Notice of References Cited	Application/Control No. 09/929,326	Applicant(s)/Patent Under Reexamination TAMAYAMA, RYUZO	
	Examiner Devona E. Faulk	Art Unit 2644	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,574,339	06-2003	Kim et al.	381/17
	B	US-5,896,358	04-1999	Endoh et al.	369/89
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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